



Trench IGBT Modules

SKiM606GD066HD

Features

- IGBT 3 Trench Gate Technology
- Solderless sinter technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Low inductance case
- Insulated by Al_2O_3 DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability, self limiting to $6 \times I_C$
- Integrated temperature sensor

Typical Applications*

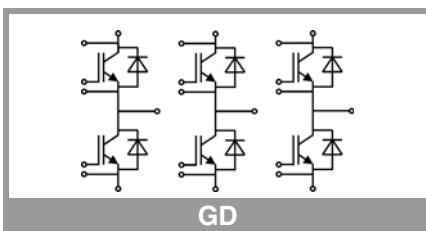
- Automotive inverter
- High reliability AC inverter wind
- High reliability AC inverter drives

Remarks

- Case temperature limited to $T_s = 125^\circ C$ max; $T_c = T_s$ (for baseplateless modules)
- Recommended $T_{op} = -40 \dots +150^\circ C$

Absolute Maximum Ratings		Values	Unit
Symbol	Conditions		
Inverter - IGBT			
V_{CES}	$T_j = 25^\circ C$	600	V
I_C	$\lambda_{paste}=0.8 \text{ W}/(\text{mK})$	640	A
	$T_j = 175^\circ C$	510	A
I_C	$\lambda_{paste}=2.5 \text{ W}/(\text{mK})$	768	A
	$T_j = 175^\circ C$	616	A
I_{Cnom}		600	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	1200	A
V_{GES}		-20 ... 20	V
t_{psc}	$V_{CC} = 360 \text{ V}$ $V_{GE} \leq 15 \text{ V}$ $V_{CES} \leq 600 \text{ V}$	6	μs
T_j		-40 ... 175	$^\circ C$
Inverse - Diode			
I_F	$\lambda_{paste}=0.8 \text{ W}/(\text{mK})$	445	A
	$T_j = 175^\circ C$	346	A
I_F	$\lambda_{paste}=2.5 \text{ W}/(\text{mK})$	550	A
	$T_j = 175^\circ C$	432	A
I_{Fnom}		600	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	1200	A
I_{FSM}	10 ms, sin 180° , $T_j = 150^\circ C$	2358	A
T_j		-40 ... 175	$^\circ C$
Module			
$I_{t(RMS)}$	$T_{terminal} = 80^\circ C$	700	A
T_{stg}		-40 ... 125	$^\circ C$
V_{isol}	AC sinus 50 Hz, $t = 1 \text{ min}$	2500	V

Symbol	Conditions	min.	typ.	max.	Unit
Inverter - IGBT					
$V_{CE(sat)}$	$I_C = 600 \text{ A}$ $V_{GE} = 15 \text{ V}$ chiplevel	1.45	1.85		V
		1.70	2.10		V
V_{CEO}	chiplevel	0.90	1.00		V
		0.85	0.90		V
r_{CE}	$V_{GE} = 15 \text{ V}$ chiplevel	0.92	1.42		$m\Omega$
		1.42	2.0		$m\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 9.6 \text{ mA}$	5	5.8	6.5	V
I_{CES}	$V_{GE} = 0 \text{ V}$, $V_{CE} = 600 \text{ V}$, $T_j = 25^\circ C$	0.1	0.3		mA
C_{ies}	$V_{CE} = 25 \text{ V}$ $V_{GE} = 0 \text{ V}$	36.96			nF
C_{oes}		2.304			nF
C_{res}		1.096			nF
Q_G	$V_{GE} = -8 \text{ V} \dots +15 \text{ V}$	4800			nC
R_{Gint}	$T_j = 25^\circ C$	0.5			Ω
$t_{d(on)}$	$V_{CC} = 300 \text{ V}$	150			ns
t_r	$I_C = 600 \text{ A}$	120			ns
E_{on}	$R_{G\ on} = 3 \Omega$	16			mJ
$t_{d(off)}$	$R_{G\ off} = 5 \Omega$	1400			ns
t_f	$di/dt_{on} = 5500 \text{ A}/\mu\text{s}$ $di/dt_{off} = 6200 \text{ A}/\mu\text{s}$	75			ns
E_{off}	$V_{GE} = +15/-7.5 \text{ V}$	53			mJ
$R_{th(j-s)}$	per IGBT, $\lambda_{paste}=0.8 \text{ W}/(\text{mK})$	0.105			K/W
$R_{th(j-s)}$	per IGBT, $\lambda_{paste}=2.5 \text{ W}/(\text{mK})$	0.078			K/W





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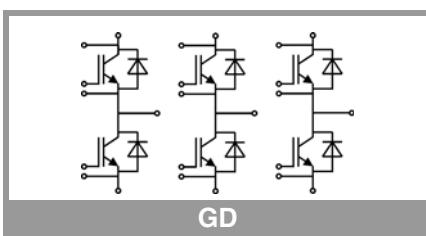
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Characteristics		Symbol	Conditions	min.	typ.	max.	Unit						
Inverse - Diode													
SKiM® 63													
$V_F = V_{EC}$	$I_F = 600 \text{ A}$		$T_j = 25^\circ C$		1.60	1.85	V						
	chiplevel		$T_j = 150^\circ C$			1.68	1.93						
V_{FO}	chiplevel		$T_j = 25^\circ C$		1.00	1.10	V						
			$T_j = 150^\circ C$			0.85	0.95						
r_F	chiplevel		$T_j = 25^\circ C$		1.00	1.25	$m\Omega$						
			$T_j = 150^\circ C$			1.38	1.63						
I_{RRM}	$I_F = 600 \text{ A}$		$T_j = 150^\circ C$		390		A						
	$di/dt_{off} = 5600 \text{ A}/\mu\text{s}$		$T_j = 150^\circ C$			85	μC						
Q_{rr}	$V_{GE} = +15/-7.5 \text{ V}$		$T_j = 150^\circ C$		21		mJ						
	$V_{CC} = 300 \text{ V}$		$T_j = 150^\circ C$			0.201							
$R_{th(j-s)}$	per Diode, $\lambda_{paste}=0.8 \text{ W}/(\text{mK})$				0.147		K/W						
	per Diode, $\lambda_{paste}=2.5 \text{ W}/(\text{mK})$					0.147							
Module													
L_{CE}					9	13	nH						
$R_{CC+EE'}$	measured per switch		$T_s = 25^\circ C$		0.3		$\text{m}\Omega$						
			$T_s = 125^\circ C$			0.5							
W					761		g						
Temperature Sensor													
R_{100}	$T_{Sensor} = 100^\circ C (R_{25} = 5 \text{ k}\Omega)$				339		Ω						
$B_{100/125}$	$R_{(T)} = R_{100} \exp[B_{100/125}(1/T-1/373)]; T[\text{K}];$				4096		K						



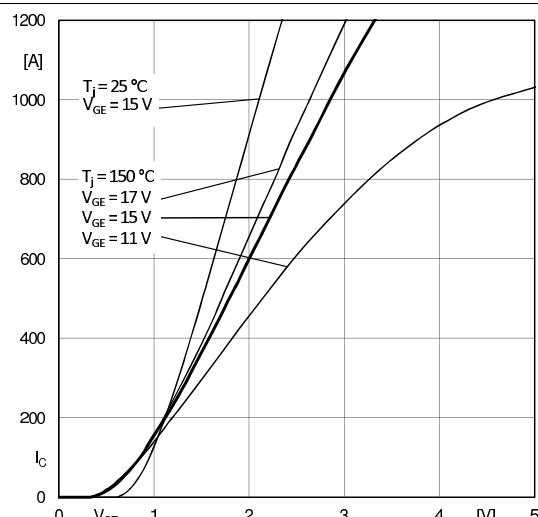
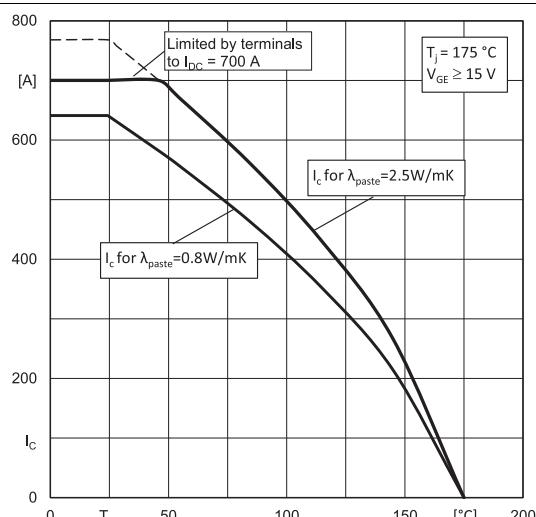
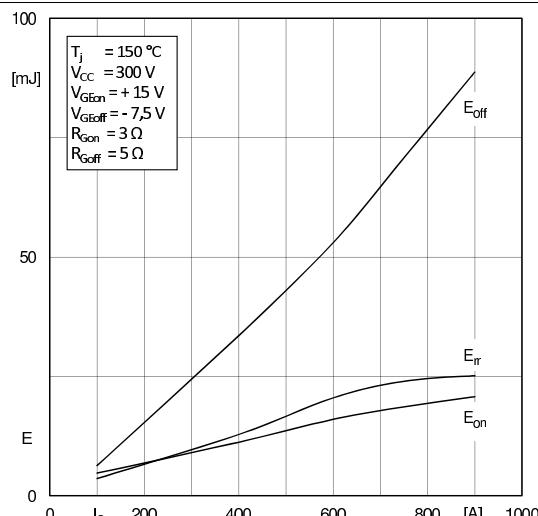
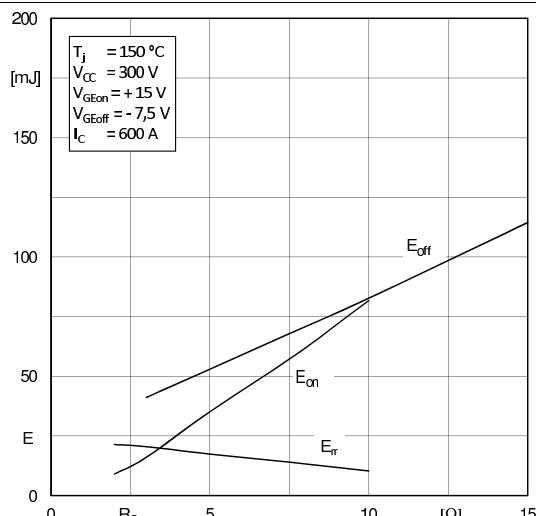
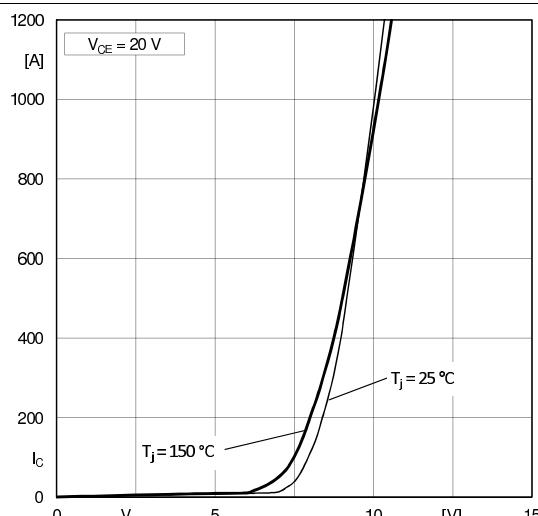
Fig. 1: Typ. output characteristic, inclusive $R_{CC} + EE'$ Fig. 2: Typ. rated current vs. temperature $I_C = f(T_S)$ Fig. 3: Typ. turn-on /-off energy = $f(I_C)$ Fig. 4: Typ. turn-on /-off energy = $f(R_G)$ 

Fig. 5: Typ. transfer characteristic

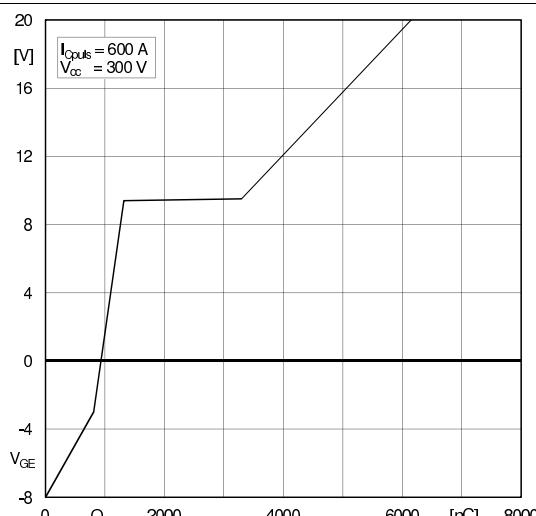


Fig. 6: Typ. gate charge characteristic

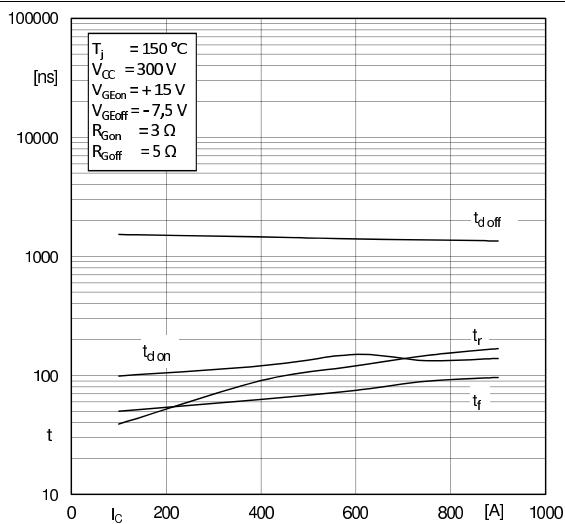


Fig. 7: Typ. switching times vs. I_C

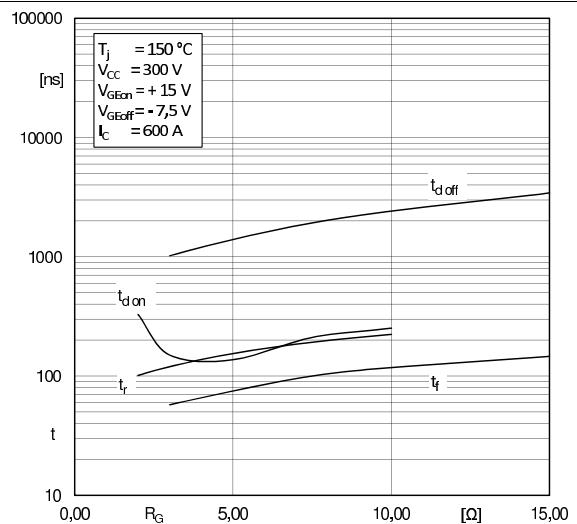


Fig. 8: Typ. switching times vs. gate resistor R_G

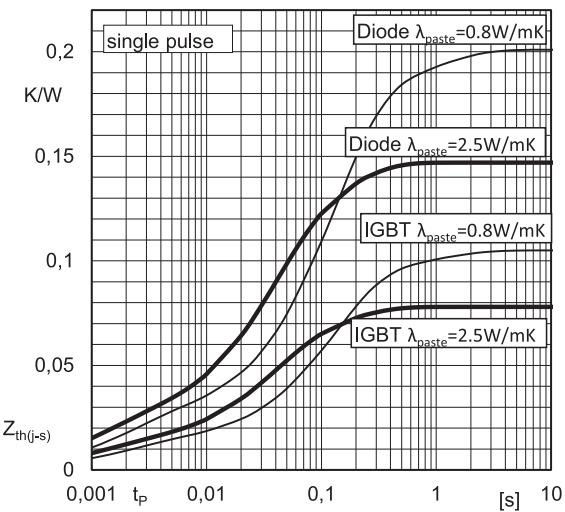


Fig. 9: Typ. transient thermal impedance

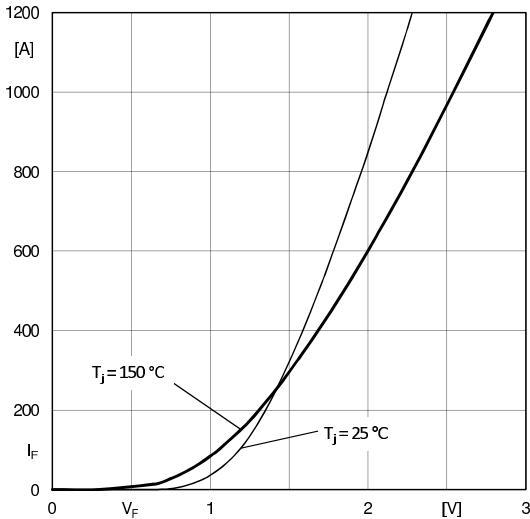


Fig. 10: Typ. CAL diode forward charact., incl. R_{CC+EE}

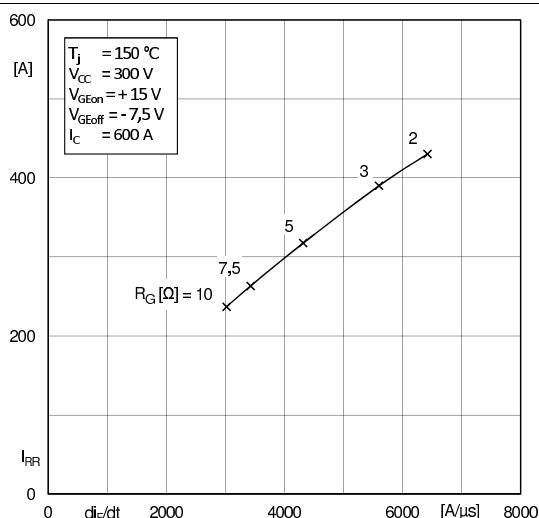


Fig. 11: Typ. CAL diode peak reverse recovery current

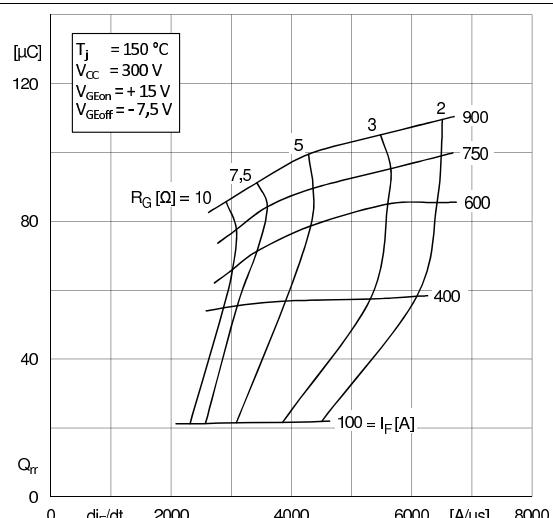
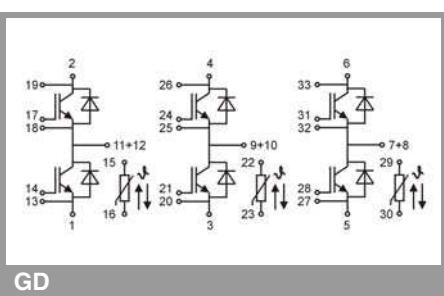
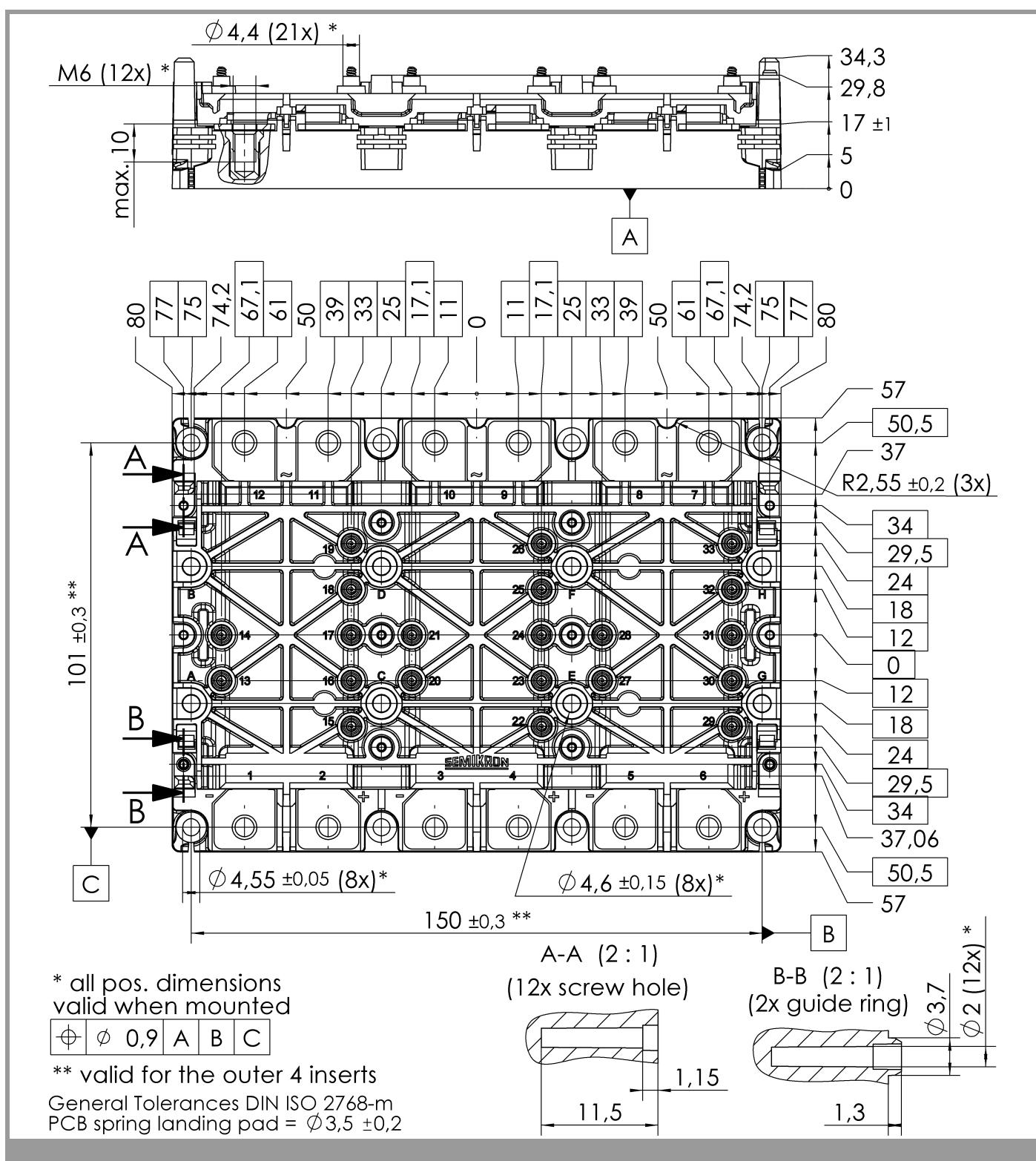


Fig. 12: Typ. CAL diode recovery charge



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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